

844.

PATENT NUMBER and  
ISSUE DATE

U.S. UTILITY Patent Application

APPL NUM	FILING DATE	CLASS	SUBCLASS	GAU	EXAMINER
10035349	10/19/2001	435	6	4819	Chakrabarti

\*\*APPLICANTS: Schneider Luke; Hall Michael; Petesch Robert;

\*\*CONTINUING DATA VERIFIED:

THIS APPLN CLAIMS BENEFIT OF 60/242,165 10/19/2000  
AND CLAIMS BENEFIT OF 60/242,398 10/19/2000

\*\* FOREIGN APPLICATIONS VERIFIED:

PG-PUB DO NOT PUBLISH ☐

RESCIND ☐

Foreign priority claimed ☐ yes ☐ no

35 USC 119 conditions met ☐ yes ☐ no

Verified and Acknowledged Examiners's initials

ATTORNEY DOCKET NO

020444-000710US

TITLE : Mass defect labeling for the determination of oligomer sequences

U.S. DEPT. OF COMM./PAT. & TM.-PTO-436L (Rev. 12-94)

NOTICE OF ALLOWANCE MAILED		CLAIMS ALLOWED		
		Total Claims		Print Claim for O.G.
		DRAWING		
		Sheets Drwg.	Figs. Drwg.	Print Fig.
		Application Examiner		
<input type="checkbox"/> <b>TERMINAL DISCLAIMER</b>		<b>PREPARED FOR ISSUE</b>		
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